GR12883

DESCRIPTION

The GR12883 is a 131072 word by 8 bits (128K x 8) non-volatile CMOS Static Ram, fabricated from advanced silicon gate CMOS technology and a high reliability lithium power cell.The power down circuit is fully automatic and is referenced at 4.5 volts. At this point the GR12883 is write protected by an internal inhibit function for Data Protection and the memory contents are retained by the lithium power source.Power down is very fast, this being essential for data integrity, taking a maximum of 15 µS (15 microseconds) to power down from 5 volts to 0 volts. This is much faster than system power failure conditions. Therefore there are no special conditions required when installing the GR12883.The GR12883 can, without external power, retain data almost indefinitely. The limiting factor will be the shelf life of the lithium cell, which is typically ten years. It is possible that this figure may be extended in view of the extremely light duty imposed upon the cell.

TECHNICAL DATA

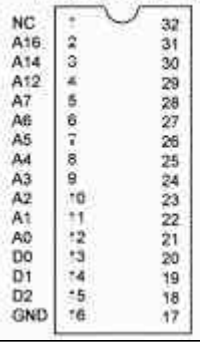
ABSOLUTE MAXIMUM RATINGS

Symbol	Min	Max	Units
Vdd	– 0.3	7.0	Volts
Vi/o	– 0.3	Vdd + 0.3	Volts
Temp	– 20	+70	deg. C

OPERATING MODE

$\overline{CE}$	$\overline{OE}$	$\overline{WR}$	MODE	OUTPUT	Idd
H	X	X	Unsel.	Hi-Z	Deselected
L	H	H	Unsel.	Hi-Z	Active
L	L	H	Read	Dout	Active
L	X	L	Write	Din	Active

PIN CONNECTIONS



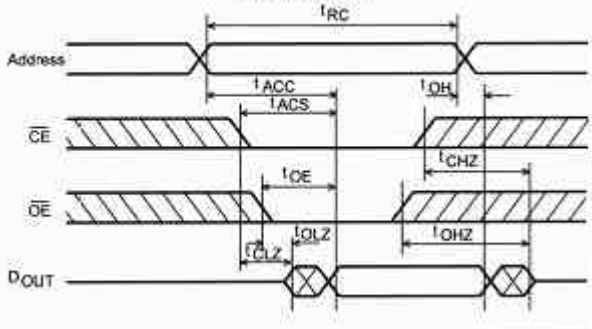
PIN DESIGNATIONS

Pin	Function
A0-A16	Address I/P's
D0-D7	Data in/out
$\overline{OE}$	Output Enable
$\overline{CE}_1$ CE_2	Chip Enable
$\overline{WR}$	Write Enable
Vdd	+5Volt Power
GND	Ground
NC	No Connect

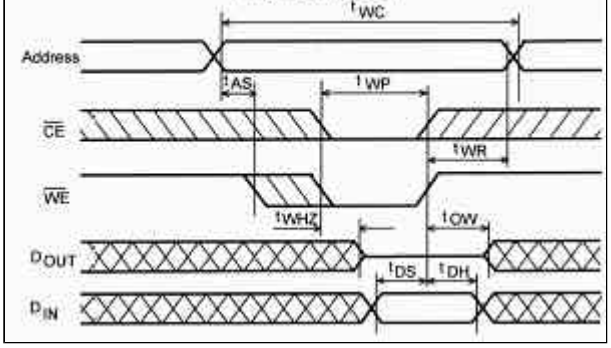
OPERATING CONDITIONS

Symbol	Min	Typ	Max	Unit
Vdd	4.75	5.0	5.5	Volts
VTH		4.5		Volts
Vin (1)	2.2			Volts
Vin (0)			0.8	Volts
Iin (CE)			1.0	LSTTL Load
Iin (any other pin)	– 1.0		+ 1.0	µA.
Vout (1)(Iout = –1mA)	2.4			Volts
Vout (0)(Iout = +2mA)			0.4	Volts
Idd (Active)		30		mA.
Idd (Deselected)		1.0		mA.
Tcycle			100	nS.
Cin (any pin)		10		pF

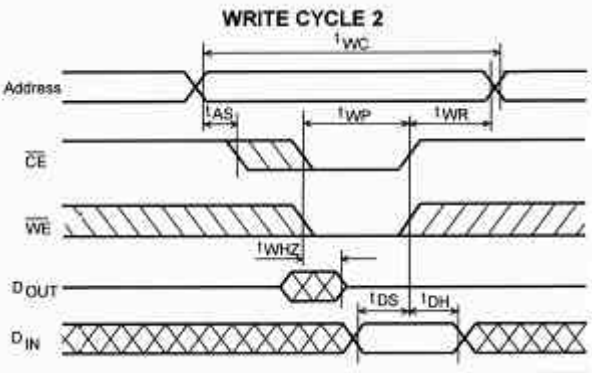
READ CYCLE



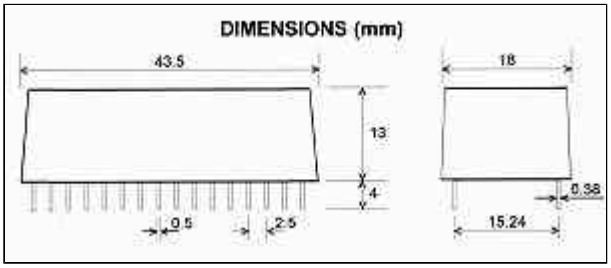
WRITE CYCLE 1



WRITE CYCLE 2



DIMENSIONS (mm)



TIMING (nS-nano seconds)

Read Cycle		100nS	
Symbol	**Parameter**	**Min**	**Max**
t_{RC}	Read cycle time	100	
t_{ACC}	Access time		100
t_{ACS}	$\overline{CE}$ to output valid		100
t_{OE}	$\overline{OE}$ to output valid		50
t_{CLZ}	$\overline{CE}$ to output active	5	
t_{OLZ}	$\overline{OE}$ to output active	5	
t_{OH}	Output hold time	10	
t_{CHZ}	$\overline{CE}$ to output disable		35
t_{OHZ}	$\overline{OE}$ to output disable		35

Write Cycle		100nS	
Symbol	**Parameter**	**Min**	**Max**
t_{WC}	Write cycle time	100	
t_{WP}	Write pulse width	75	
t_{AS}	Address setup time	0	
t_{WR}	Write recovery time	0	
t_{WHZ}	$\overline{WR}$ to output disable		35
t_{OW}	Output active from $\overline{WR}$	5	
t_{DS}	Data setup time	40	
t_{DH}	Data HOLD TIME	0	

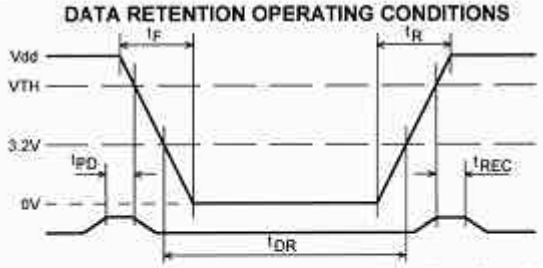
Notes

1.$\overline{WE}$ must be high during address transitions.

2.A Write occurs during the overlap of a low $\overline{CE}_1$, a high CE_2 and a low $\overline{WE}$.

3.$\overline{WE}$ is high for a read cycle.

DATA RETENTION OPERATING CONDITIONS



Symbol	Parameter	Min	Typ	Max	Units
Vdd	Operating supply voltage	4.75	5.0	5.50	Volts
VTH	Data retention voltage		4.5		Volts
t_F	Vdd slew to 0V	15			µS
t_R	Vdd slew 0V to 5.0V	15			µS
t_{REC}	CE to O/P valid from power up			15	µS
t_{DR}	Data retention time		10		Years
t_{PD}	CE at Vin(1) before power down	0			µS

APPLICATION

When powered down, the GR12883 is transportable and data can be moved from system to system, this makes it ideal for programme development, data collection in data loggers, programme changes in process control, automation and robotics and user definable lookup tables, etc.

Additional information available through our technical sevices department.